

		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 30-5004(4015)		SERIAL NO. 91783377 07405492	
		LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					
		APPLICANT Vladimir Segal et al.				FILING DATE December 16, 1999	
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*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA						
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		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
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U.S. DEPARTMENT OF COMMERCE
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30-5022(4015)SERIAL NO.
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February 13, 2001GROUP
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Jan	AL		S. Ferrasse et al., "Texture evolution during equal channel angular extrusion Part I. Effect of route, number of passes and initial texture", Materials Science and Engineering, Vol. 368, March 15, 2004, pp. 28-40.
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Jan	AT		Yoshinori Iwahashi et al., "Microstructural Characteristics of Ultrafine-Grained Aluminum Produced Using Equal-Channel Angular Pressing", Metallurgical and Materials Transactions, Vol. 29A, pp. 2245-2252, September 1998.

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